



Reviewer's Recognition

The Editor-in-Chief and Editorial Board of the *ASME Journal of Fluids Engineering* would like to thank all of the reviewers for volunteering their expertise and time reviewing manuscripts in 2022. Serving as reviewers for the journal is a critical service necessary to maintain the quality of our publication and to provide the authors with a valuable peer review of their work. Below is a complete list of reviewers for 2022. We would also like to acknowledge three outstanding Reviewers of the Year.

2022 Reviewers of the Year

Deify Law — California State University, Fresno, USA

Gerard Bois — Arts et Métiers ParisTech, France

Lei Tan — Tsinghua University, China

The Reviewers of the Year Award is given to reviewers who have made an outstanding contribution to the journal in terms of the quantity, quality, and turnaround time of reviews completed during the past 12 months. The prize includes a Wall Plaque, 50 free downloads from the ASME Digital Collection, and a one year free subscription to the journal.

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